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With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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International Rectifier

IRL3103PbF

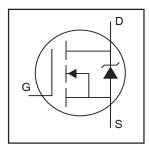
HEXFET® Power MOSFET

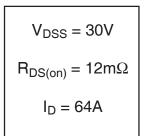
- Advanced Process Technology
- Ultra Low On-Resistance
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Lead-Free

Description

Advanced HEXFET® Power MOSFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.







Absolute Maximum Ratings

	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	64	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	45	А
I _{DM}	Pulsed Drain Current ①	220	
P _D @T _C = 25°C	Power Dissipation	94	W
	Linear Derating Factor	0.63	W/°C
V_{GS}	Gate-to-Source Voltage	± 16	V
I _{AR}	Avalanche Current①	34	А
E _{AR}	Repetitive Avalanche Energy①	22	mJ
dv/dt	Peak Diode Recovery dv/dt ③	5.0	V/ns
TJ	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting torque, 6-32 or M3 srew	10 lbf•in (1.1N•m)	

Thermal Resistance

	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case		1.6	
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface	0.50		°C/W
$R_{\theta JA}$	Junction-to-Ambient		62	

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International TOR Rectifier

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	30			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.028		V/°C	Reference to 25°C, I _D = 1mA
_				12	mΩ	V _{GS} = 10V, I _D = 34A ④
R _{DS(on)}	Static Drain-to-Source On-Resistance			16	11152	V _{GS} = 4.5V, I _D = 28A ④
V _{GS(th)}	Gate Threshold Voltage	1.0			V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
9 _{fs}	Forward Transconductance	22			S	V _{DS} = 25V, I _D = 34A@
	Duning to Common London Commont			25	μΑ	$V_{DS} = 30V, V_{GS} = 0V$
I _{DSS}	Drain-to-Source Leakage Current			250	μΛ	$V_{DS} = 24V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
	Gate-to-Source Forward Leakage			100		V _{GS} = 16V
I _{GSS}	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -16V
Qg	Total Gate Charge			33		I _D = 34A
Q _{gs}	Gate-to-Source Charge			5.9	nC	$V_{DS} = 24V$
Q _{gd}	Gate-to-Drain ("Miller") Charge			17	1	$V_{GS} = 4.5V$, See Fig. 6 and 13
t _{d(on)}	Turn-On Delay Time		8.9			V _{DD} = 15V
t _r	Rise Time		120		1	$I_D = 34A$
t _{d(off)}	Turn-Off Delay Time		14]	$R_G = 1.8\Omega$
t _f	Fall Time		9.1			V _{GS} = 4.5V, See Fig. 10 ⊕
	Internal Drain Inductance		4.5			Between lead,
L _D	internal Dialit inductance		4.5		l	6mm (0.25in.)
L _S	Internal Source Inductance		7.5		nH	from package
						and center of die contact
C _{iss}	Input Capacitance		1650			V _{GS} = 0V
Coss	Output Capacitance		650		1	$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance		110		pF	f = 1.0MHz, See Fig. 5
E _{AS}	Single Pulse Avalanche Energy@		1320©	130⑥	mJ	I _{AS} = 34A, L = 0.22mH

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current		64	. A	MOSFET symbol	
	(Body Diode)				showing the	
I _{SM}	Pulsed Source Current			220	'`	integral reverse
	(Body Diode)①		220	220	p-n junction diode.	
V _{SD}	Diode Forward Voltage			1.2	V	$T_J = 25$ °C, $I_S = 34A$, $V_{GS} = 0V$ ④
t _{rr}	Reverse Recovery Time		57	86	ns	$T_J = 25^{\circ}C, I_F = 34A$
Q _{rr}	Reverse Recovery Charge		110	170	nC	di/dt = 100A/µs ④
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)				

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- $\label{eq:starting} \begin{array}{ll} \text{ Starting T}_J = 25^{\circ}\text{C}, \ L = 220 \mu\text{H} \\ \text{R}_G = 25 \Omega, \ \text{I}_{AS} = 34 \text{A}, \ \text{V}_{GS} = 10 \text{V (See Figure 12)} \end{array}$
- $\label{eq:loss} \begin{array}{l} \mbox{(3)} \ I_{SD} \leq 34A, \ di/dt \leq 120A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \\ \mbox{$T_J \leq 175^{\circ}C$} \end{array}$
- 4 Pulse width $\leq 400 \mu s$; duty cycle $\leq 2\%$.
- ⑤ This is a typical value at device destruction and represents operation outside rated limits.
- $^{\circ}$ This is a calculated value limited to T_J = 175°C .

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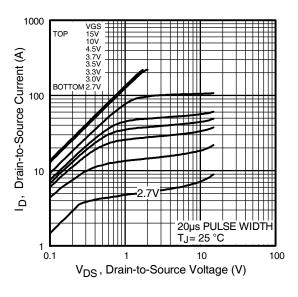


Fig 1. Typical Output Characteristics

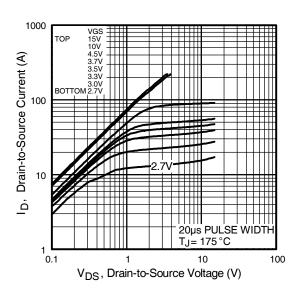


Fig 2. Typical Output Characteristics

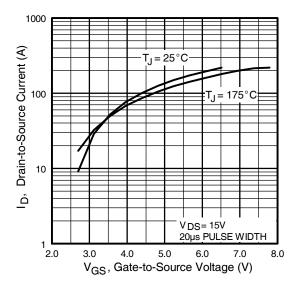


Fig 3. Typical Transfer Characteristics

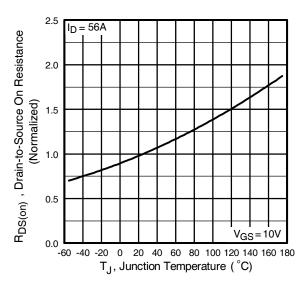


Fig 4. Normalized On-Resistance Vs. Temperature

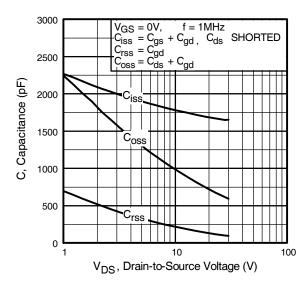


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

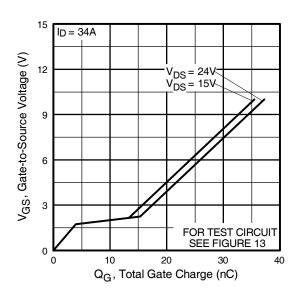


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

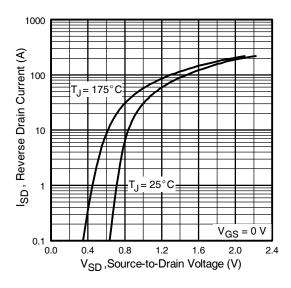


Fig 7. Typical Source-Drain Diode Forward Voltage

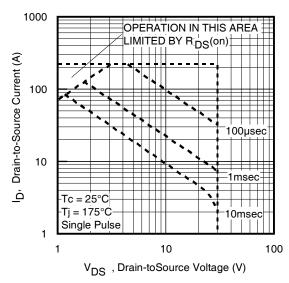


Fig 8. Maximum Safe Operating Area

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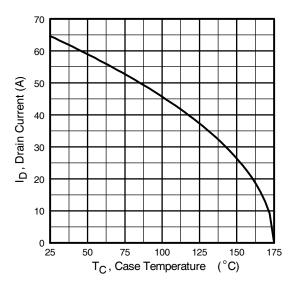


Fig 9. Maximum Drain Current Vs. Case Temperature

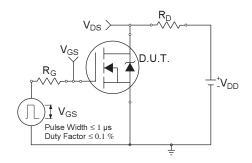


Fig 10a. Switching Time Test Circuit

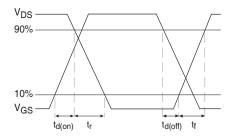


Fig 10b. Switching Time Waveforms

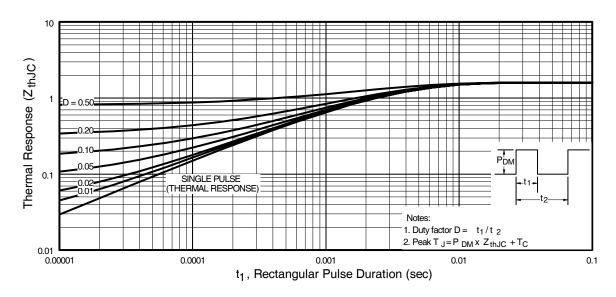


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

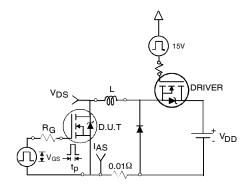


Fig 12a. Unclamped Inductive Test Circuit

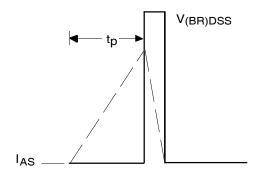


Fig 12b. Unclamped Inductive Waveforms

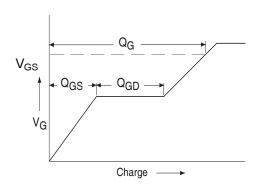


Fig 13a. Basic Gate Charge Waveform

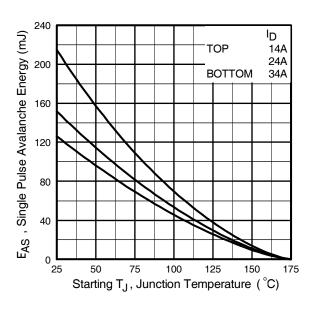


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

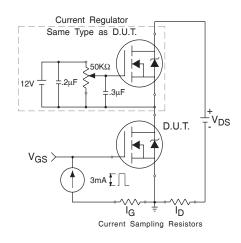
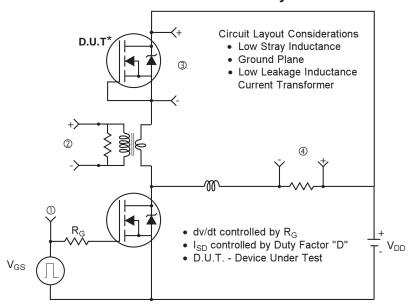


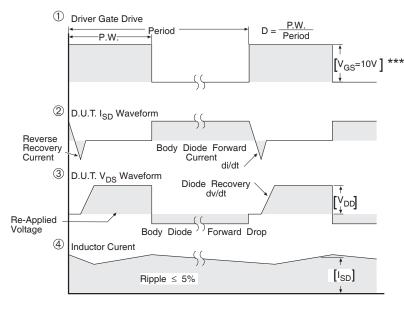
Fig 13b. Gate Charge Test Circuit

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Peak Diode Recovery dv/dt Test Circuit



* Reverse Polarity of D.U.T for P-Channel

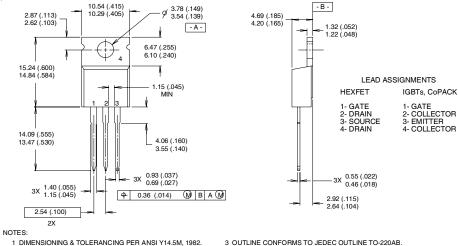


*** V_{GS} = 5.0V for Logic Level and 3V Drive Devices

Fig 14. For N-channel HEXFET® power MOSFETs

TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



- 2 CONTROLLING DIMENSION: INCH
- 4 HEATSINK & LEAD MEASUREMENTS DO NOT INCLUDE BURRS.

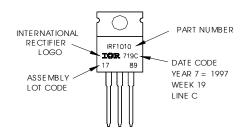
TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010

LOT CODE 1789 ASSEMBLED ON WW 19, 1997

IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position indicates "Lead-Free'



Data and specifications subject to change without notice. This product has been designed and qualified for the industrial market. Qualification Standards can be found on IR's Web site.



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Note: For the most current drawings please refer to the IR website at: http://www.irf.com/package/